

MILITARY DATA SHEET

Original Creation Date: 03/12/96 Last Update Date: 07/30/96

Last Major Revision Date: 03/12/96

QUAD 2-INPUT NAND BUFFER (OPEN COLLECTOR)

General Description

MN54F38-X REV 1A0

The device contains four independent gates, each of which performs the logic NAND function. The open-collector outputs require external pull-up resistors for proper logical operation.

Industry Part Number

NS Part Numbers

54F38

54F38DMQB 54F38FMQB 54F38LMQB

Prime Die

M038

Processing

MIL-STD-883, Method 5004

Quality Conformance Inspection

MIL-STD-883, Method 5005

Subgrp Description Temp (°C)

| 1 | Static tests at | +25 |
|----|---------------------|------|
| 2 | Static tests at | +125 |
| 3 | Static tests at | -55 |
| 4 | Dynamic tests at | +25 |
| 5 | Dynamic tests at | +125 |
| 6 | Dynamic tests at | -55 |
| 7 | Functional tests at | +25 |
| 8A | Functional tests at | +125 |
| 8B | Functional tests at | -55 |
| 9 | Switching tests at | +25 |
| 10 | Switching tests at | +125 |
| 11 | Switching tests at | -55 |
| | | |

(Absolute Maximum Ratings) (Note 1)

| Storage Temperature | -65 C to +150 C | | | |
|--------------------------------------------------------------------------------------------------|--------------------------------|--|--|--|
| Ambient Temperature under Bias | -55 C to +125 C | | | |
| Junction Temperature under Bias | -55 C to +175 C | | | |
| Vcc Pin Potential to Ground Pin | -0.5V to +7.0V | | | |
| Input Voltage (Note 2) | -0.5V to +7.0V | | | |
| Input Current (Note 2) | -0.30 to +7.00 | | | |
| | -30 mA to $+5.0$ mA | | | |
| Voltage Applied to Output in HIGH State (with Vcc=0V) Standard Output TRI-STATE Output | -0.5V to Vcc -0.5V to +5.5V | | | |
| Current Applied to Output in LOW State (Max) | twice the rated Iol(mA) | | | |
| ESD Last Passing Voltage (Min) | 4000V | | | |
| Note 1: Absolute Maximum ratings are those values be have its useful life impaired. Functional o | | | | |
| implied. Note 2: Either voltage limit or current limit is sufficient to protect inputs. | | | | |

Recommended Operating Conditions

| Free Air Ambient Temperature Commercial Military | 0 C to +70 C -55 C to +125 C |
|--------------------------------------------------------|---------------------------------|
| Supply Voltage | |
| Military | +4.5V to +5.5V |
| Commercial | +4.5V to +5.5V |

Electrical Characteristics

DC PARAMETER

(The following conditions apply to all the following parameters, unless otherwise specified.) DC: VCC 4.5V to 5.5V, Temp range: -55C to 125C

| SYMBOL | PARAMETER | CONDITIONS | NOTES | PIN- NAME | MIN | MAX | UNIT | SUB- GROUPS |
|--------|------------------------------|----------------------------------------------------|-------|--------------|-----|------|------|----------------|
| IIH | Input High Current | VCC=5.5V, VM=2.7V, VINH=5.5V, VINL=0.0V | 1, 3 | INPUTS | | 20 | uA | 1, 2, |
| IBVI | Input High Current | VCC=5.5V, VM=7.0V, VINH=5.5V, VINL=0.0V | 1, 3 | INPUTS | | 100 | uA | 1, 2, |
| IIL | Input LOW Current | VCC=5.5V, VM=0.5V, VINH=5.5V, VINL=0.0V | 1, 3 | INPUTS | | -1.2 | mA | 1, 2, |
| IOH | Open Collector Output | VCC=4.5V, VM=4.5V, VIL=0.8V, VINH=5.5V | 1, 3 | OUTPUTS | | 250 | uA | 1, 2, |
| VOLB | Output LOW Voltage | VCC=4.5V, VIL=0.8V, VIH=2.0V, IOLB=48mA, VINH=5.5V | 1, 3 | OUTPUTS | | .55 | V | 1, 2, |
| VCD | Input Clamp Diode Voltage | VCC=4.5V, IM=-18mA, VINH=5.5V | 1, 3 | INPUTS | | -1.2 | V | 1, 2, |
| ICCH | Supply Current | VCC=5.5V, VINL=0.0V, VINH=5.5V | 1, 3 | VCC | | 7.0 | mA | 1, 2, |
| ICCL | Supply Current | VCC=5.5V, VINL=0.0V, VINH=5.5V | 1, 3 | VCC | | 30.0 | mA | 1, 2, |

AC PARAMETER

(The following conditions apply to all the following parameters, unless otherwise specified.) AC: CL=50pf, RL=500 OHMS, TR=2.5ns, TF=2.5ns SEE AC FIGS

| tpLH | Propagation Delay | VCC=5.0V @25C, VCC=4.5V & 5.5V @-55/125C | 2, 4 | An/Bn to Ōn | 6.5 | 12.5 | ns | 9 |
|------|-------------------|------------------------------------------|------|----------------|-----|------|----|--------|
| | | | 2, 4 | An/Bn to On | 6.5 | 14.5 | ns | 10, 11 |
| tpHL | Propagation Delay | VCC=5.0V @25C, VCC=4.5V & 5.5V @-55/125C | 2, 4 | An/Bn to Ōn | 1.0 | 5.0 | ns | 9 |
| | | | 2, 4 | An/Bn to Ōn | 1.0 | 5.5 | ns | 10, 11 |

- Screen tested 100% on each device at +25C, +125C & -55C temperature, subgroups A1, 2,
- Screen tested 100% on each device at +25C temperature only, subgroup A9. Note 3:
- Sample tested (Method 5005, Table 1) on each MFG. lot at +25C, +125C & -55C temperature, subgroups A1, 2, 3, 7 & 8.

 Sample tested (Method 5005, table 1) on each MFG. lot at +25C subgroup A9, and periodically at +125C & -55C temperature, subgroups 10 & 11. Note 4:

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Datasheets for electronics components.